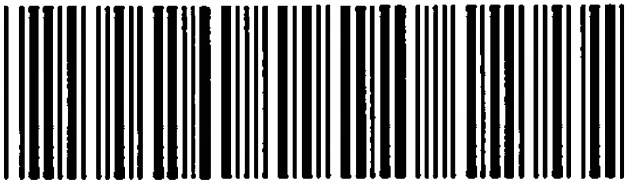


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/640,341	CHEN, MI-CHIEN	
	Examiner	Art Unit	
	James W. Cranson	2875	

SEARCHED			
Class	Subclass	Date	Examiner
362	31	2/4/2005	JWC
362	26	2/4/2005	JWC
362	561	2/4/2005	JWC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
362/31.ccls.	2/4/2005	JWC